STB34NM60ND, STF34NM60ND, STP34NM60ND, STW34NM60ND

N-channel 600 V, 0.097 Ω typ., 29 A FDmesh[™] II Power MOSFET (with fast diode) in D²PAK, TO-220FP, TO-220 and TO-247

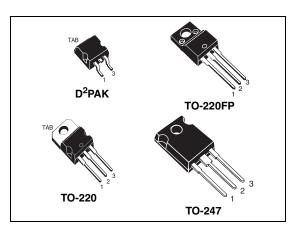
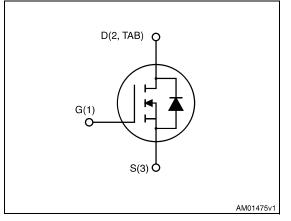


Figure 1. Internal schematic diagram



Datasheet — production data

Features

Order codes	V _{DS} @T _J max.	R _{DS(on)} max.	I _D
STB34NM60ND			
STF34NM60ND		0 110 0	00.4
STP34NM60ND	650 V	0.110 Ω	29 A
STW34NM60ND			

- The world's best R_{DS(on)} in TO-220 amongst the fast recovery diode devices
- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance
- Extremely high dv/dt and avalanche capabilities

Applications

• Switching applications

Description

These devices are N-channel FDmesh[™] V Power MOSFETs produced using ST's MDmesh[™] V technology, which is based on an innovative proprietary vertical structure. The resulting product boasts an extremely low on-resistance that is unrivaled among silicon-based Power MOSFETs, and superior switching performance with intrinsic fast-recovery body diode.

Order codes	Marking	Packages	Packaging
STB34NM60ND		D ² PAK	Tape and reel
STF34NM60ND	34NM60ND	TO-220FP	
STP34NM60ND	3411100110	TO-220	Tube
STW34NM60ND		TO-247	

DocID18099 Rev 6

www.st.com

This is information on a product in full production.

Contents

1	Electrical ratings	5
2	Electrical characteristics 4 2.1 Electrical characteristics (curves)	
3	Test circuits)
4	Package mechanical data 10)
5	Packaging mechanical data 19	¢
6	Revision history	I



1 Electrical ratings

Cumbal	Deveneter	Value		
Symbol	Parameter	D ² PAK, TO-220, TO-247	TO-220FP	
V_{DS}	Drain-source voltage	600		V
V _{GS}	Gate- source voltage	± 25		V
۱ _D	Drain current (continuous) at $T_{C} = 25 \ ^{\circ}C$	29 29(1		A
Ι _D	Drain current (continuous) at T _C = 100 °C	18	18 ⁽¹⁾	А
I _{DM} ⁽²⁾	Drain current (pulsed)	116	116 ⁽¹⁾	Α
P _{TOT}	Total dissipation at $T_{C} = 25 \ ^{\circ}C$	190 4		W
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; T_C =25 °C)		2500	v
dv/dt ⁽³⁾	Peak diode recovery voltage slope	40		V/ns
T _{stg}	Storage temperature - 55 to 150		O	
Т _Ј	Max. operating junction temperature	150		

Table 2.	Absolute	maximum	ratings

1. Current limited by package

2. Pulse width limited by safe operating area

3. I_{SD} \leq 29 A, di/dt \leq 600 A/µs, V_{DD} = 80% V_{(BR)DSS}, V_DSPeak < V_{(BR)DSS}

Table 3. Thermal data

Symbol	Parameter	TO-220	TO-247	D ² PAK	TO-220FP	Unit
R _{thj-case}	Thermal resistance junction-case max		0.66		3.1	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	62.5 50		62.5	°C/W	
R _{thj-pcb} ⁽¹⁾	Thermal resistance junction-pcb max	30			°C/W	

1. When mounted on FR-4 board of 1 inch², 2 oz Cu.

Table 4. Avalanche characteristics

Symbol	Parameter	Max value	Unit
I _{AR}	Avalanche current, repetitive or not- repetitive (pulse width limited by T _J max)	7	A
E _{AS}	Single pulse avalanche energy (starting $T_J = 25 \text{ °C}$, $I_D = I_{AR}$, $V_{DD} = 50 \text{ V}$)	110	mJ



2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage (V _{GS} = 0)	I _D = 1 mA	600			۷
1	Zero gate voltage	V _{DS} = 600 V			1	μA
IDSS	drain current (V _{GS} = 0)	$V_{DS} = 600 \text{ V}, \text{ T}_{C} = 125 ^{\circ}\text{C}$			100	μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 25 V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on resistance	V_{GS} = 10 V, I _D = 14.5 A		0.097	0.110	Ω

Table 5. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	2785	-	pF
C _{oss}	Output capacitance	V _{DS} = 50 V, f = 1 MHz,	-	168	-	pF
C _{rss}	Reverse transfer capacitance	V _{GS} = 0	-	5	-	pF
C _{oss eq.} ⁽¹⁾	Equivalent output capacitance	$V_{GS} = 0, V_{DS} = 0$ to 480 V	-	438	-	pF
t _{d(on)}	Turn-on delay time		-	30	-	ns
t _r	Rise time	$V_{DD} = 300 \text{ V}, \text{ I}_{D} = 14.5 \text{ A}$	-	53.4	-	ns
t _{d(off)}	Turn-off delay time	$R_G = 4.7 \Omega, V_{GS} = 10 V$ (see <i>Figure 18</i> and <i>23</i>)	-	111	-	ns
t _f	Fall time		-	61.8	-	ns
Qg	Total gate charge	V _{DD} = 480 V, I _D = 29 A,	-	80.4	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V,	-	16	-	nC
Q _{gd}	Gate-drain charge	(see Figure 19)	-	41.4	-	nC
Rg	Gate input resistance	f=1 MHz, open drain	-	2.87	-	Ω

Table 6. Dynamic

1. $C_{oss\ eq}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		29	А
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		116	А
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 29 A, V _{GS} = 0	-		1.6	V
t _{rr}	Reverse recovery time	I _{SD} = 29 A, V _{DD} = 60 V	-	175		ns
Q _{rr}	Reverse recovery charge	di/dt=100 A/µs	-	1.4		μC
I _{RRM}	Reverse recovery current	(see Figure 20)	-	16		А
t _{rr}	Reverse recovery time	$I_{SD} = 29 \text{ A}, V_{DD} = 60 \text{ V}$	-	255		ns
Q _{rr}	Reverse recovery charge	di/dt=100 A/μs, Τ ₁ = 150 °C	-	2.6		μC
I _{RRM}	Reverse recovery current	(see Figure 20)	-	20		А

Table 7. Source drain diode

1. Pulse width limited by safe operating area

2. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%.



2.1 Electrical characteristics (curves)

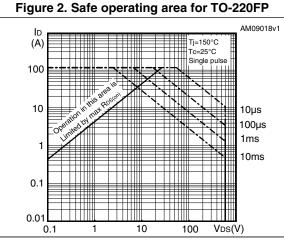


Figure 4. Safe operating area for TO-220 and D²PAK

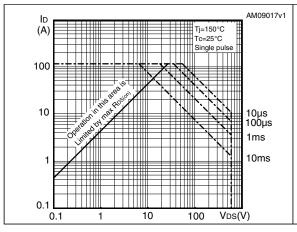


Figure 6. Safe operating area for TO-247

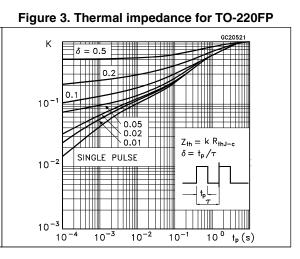


Figure 5. Thermal impedance for TO-220 and D²PAK

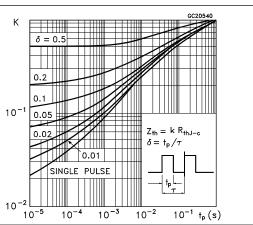
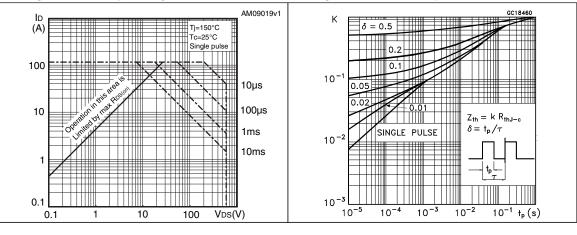


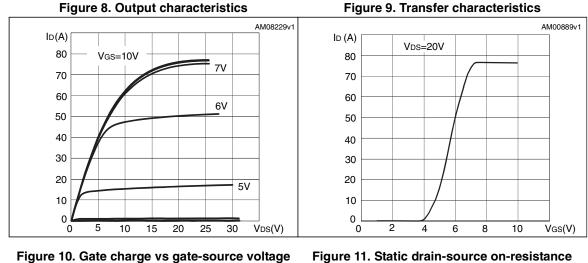
Figure 7. Thermal impedance for TO-247

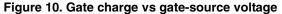


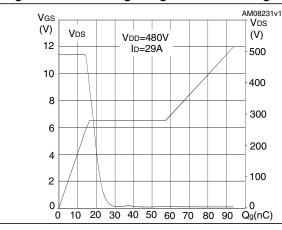
DocID18099 Rev 6



6/22







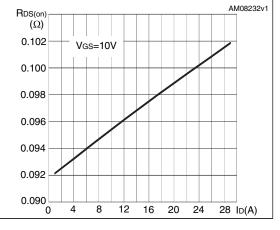
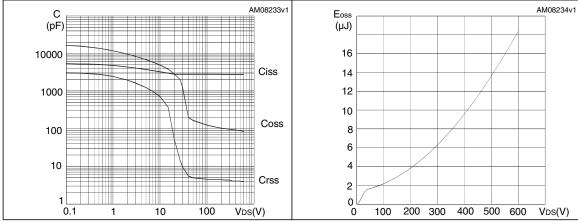


Figure 12. Capacitance variations





57

Figure 14. Normalized gate threshold voltage vs temperature

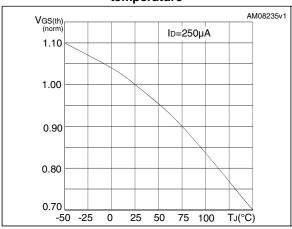


Figure 15. Normalized on-resistance vs temperature

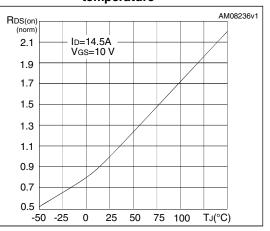
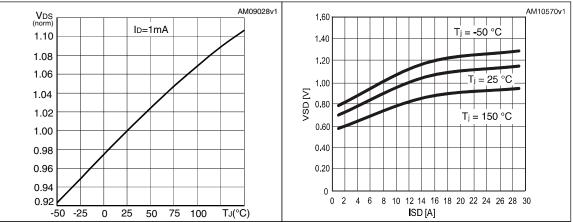


Figure 16. Normalized V_{DS} vs temperature

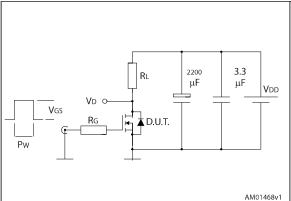






3 Test circuits

Figure 18. Switching times test circuit for resistive load



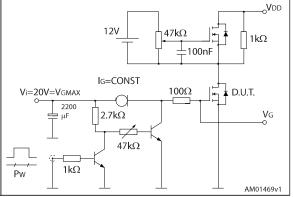


Figure 21. Unclamped inductive load test circuit

Figure 19. Gate charge test circuit

Figure 20. Test circuit for inductive load switching and diode recovery times

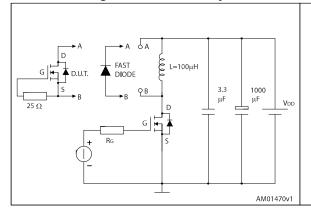
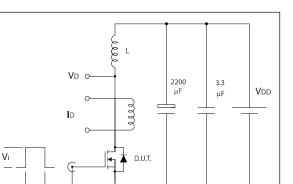
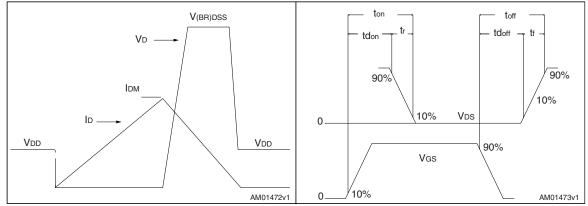


Figure 22. Unclamped inductive waveform



eform Figure 23. Switching time waveform

Pw





DocID18099 Rev 6

AM01471v1

4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.

10/22



		mm	
Dim.	Min.	Тур.	Max.
А	4.40		4.60
A1	0.03		0.23
b	0.70		0.93
b2	1.14		1.70
с	0.45		0.60
c2	1.23		1.36
D	8.95		9.35
D1	7.50		
E	10		10.40
E1	8.50		
е		2.54	
e1	4.88		5.28
Н	15		15.85
J1	2.49		2.69
L	2.29		2.79
L1	1.27		1.40
L2	1.30		1.75
R		0.4	
V2	0°		8°

Table 8. D²PAK (TO-263) mechanical data



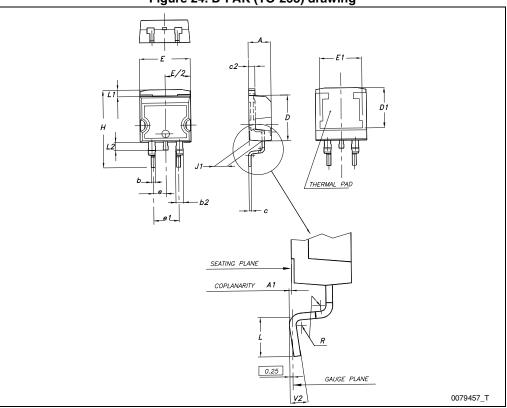
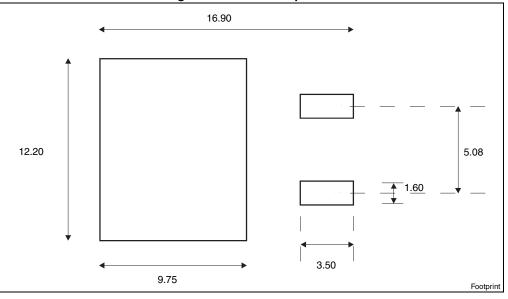


Figure 24. D²PAK (TO-263) drawing

Figure 25. D²PAK footprint^(a)



a. All dimension are in millimeters

	mm			
Dim.	Min.	Тур.	Max.	
А	4.4		4.6	
В	2.5		2.7	
D	2.5		2.75	
E	0.45		0.7	
F	0.75		1	
F1	1.15		1.70	
F2	1.15		1.70	
G	4.95		5.2	
G1	2.4		2.7	
Н	10		10.4	
L2		16		
L3	28.6		30.6	
L4	9.8		10.6	
L5	2.9		3.6	
L6	15.9		16.4	
L7	9		9.3	
Dia	3		3.2	

Table 9. TO-220FP mechanical data



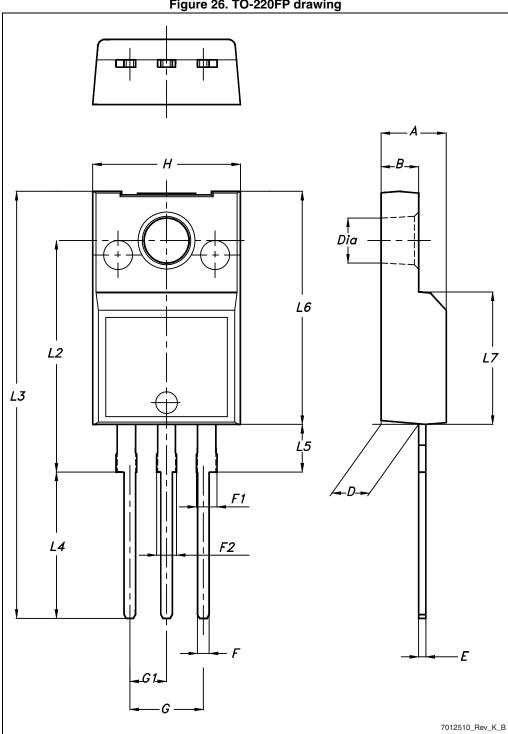


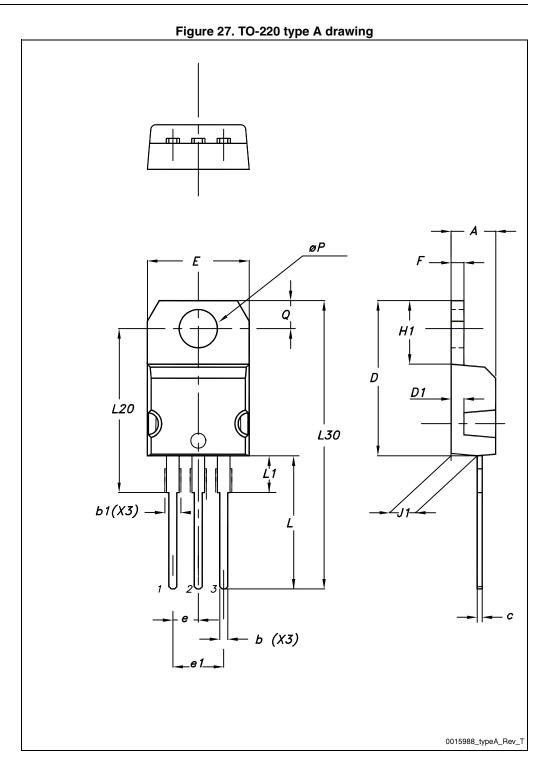
Figure 26. TO-220FP drawing



Dim.	mm			
	Min.	Тур.	Max.	
A	4.40		4.60	
b	0.61		0.88	
b1	1.14		1.70	
с	0.48		0.70	
D	15.25		15.75	
D1		1.27		
E	10		10.40	
е	2.40		2.70	
e1	4.95		5.15	
F	1.23		1.32	
H1	6.20		6.60	
J1	2.40		2.72	
L	13		14	
L1	3.50		3.93	
L20		16.40		
L30		28.90		
ØР	3.75		3.85	
Q	2.65		2.95	

Table 10. TO-220 type A mechanical data



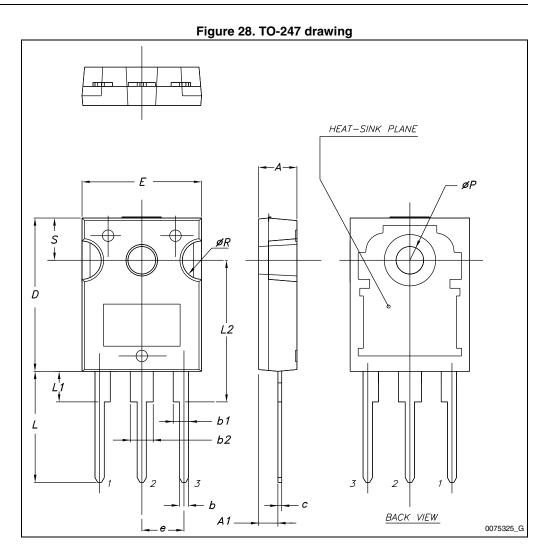




		mm.			
Dim.					
	Min.	Тур.	Max.		
A	4.85		5.15		
A1	2.20		2.60		
b	1.0		1.40		
b1	2.0		2.40		
b2	3.0		3.40		
с	0.40		0.80		
D	19.85		20.15		
E	15.45		15.75		
е	5.30	5.45	5.60		
L	14.20		14.80		
L1	3.70		4.30		
L2		18.50			
ØP	3.55		3.65		
ØR	4.50		5.50		
S	5.30	5.50	5.70		

Table 11. TO-247 mechanical data







5 Packaging mechanical data

Таре			Reel		
Dim.	mm		Dim	mm	
	Min.	Max.	Dim.	Min.	Max.
A0	10.5	10.7	Α		330
B0	15.7	15.9	В	1.5	
D	1.5	1.6	С	12.8	13.2
D1	1.59	1.61	D	20.2	
E	1.65	1.85	G	24.4	26.4
F	11.4	11.6	N	100	
K0	4.8	5.0	Т		30.4
P0	3.9	4.1			
P1	11.9	12.1		Base qty	1000
P2	1.9	2.1		Bulk qty	1000
R	50				
Т	0.25	0.35]		
W	23.7	24.3			

Table 12. D²PAK (TO-263) tape and reel mechanical data



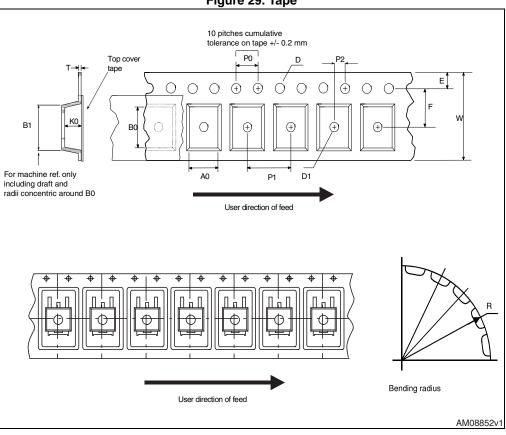
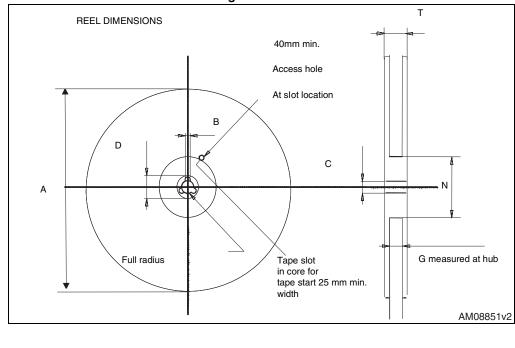


Figure 29. Tape

Figure 30. Reel





6 Revision history

Date	Revision	Changes	
04-Nov-2010	1	Initial release.	
18-Apr-2011	2	Corrected E _{AS} value in <i>Table 4: Avalanche characteristics</i>	
14-Sep-2011	3	Added order code in D ² PAK and TO-220FP Updated <i>Table 1: Device summary, Table 2: Absolute maximum</i> <i>ratings</i> and <i>Table 3: Thermal data.</i> Updated <i>Section 4: Package mechanical data.</i> Added <i>Section 5: Packaging mechanical data.</i> Minor text changes.	
29-Dec-2011	4	Updated description in cover page.	
01-Oct-2012	5	Updated title on the cover page. Updated figures <i>10</i> , <i>11</i> , <i>16</i> and <i>17</i> . Updated <i>Section 4: Package mechanical data</i> . Minor text changes.	
02-Oct-2013	6	 Modified: E_{AS} in <i>Table 4</i>, C_{oss eq.} typical value in <i>Table 6</i>, <i>Figure 13</i> Modified: <i>Figure 18</i>, <i>19</i>, <i>20</i> and <i>21</i> Minor text changes 	



Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

ST PRODUCTS ARE NOT DESIGNED OR AUTHORIZED FOR USE IN: (A) SAFETY CRITICAL APPLICATIONS SUCH AS LIFE SUPPORTING, ACTIVE IMPLANTED DEVICES OR SYSTEMS WITH PRODUCT FUNCTIONAL SAFETY REQUIREMENTS; (B) AERONAUTIC APPLICATIONS; (C) AUTOMOTIVE APPLICATIONS OR ENVIRONMENTS, AND/OR (D) AEROSPACE APPLICATIONS OR ENVIRONMENTS, WHERE ST PRODUCTS ARE NOT DESIGNED FOR SUCH USE, THE PURCHASER SHALL USE PRODUCTS AT PURCHASER'S SOLE RISK, EVEN IF ST HAS BEEN INFORMED IN WRITING OF SUCH USAGE, UNLESS A PRODUCT IS EXPRESSLY DESIGNATED BY ST AS BEING INTENDED FOR "AUTOMOTIVE, AUTOMOTIVE SAFETY OR MEDICAL" INDUSTRY DOMAINS ACCORDING TO ST PRODUCT DESIGN SPECIFICATIONS. PRODUCTS FORMALLY ESCC, QML OR JAN QUALIFIED ARE DEEMED SUITABLE FOR USE IN AEROSPACE BY THE CORRESPONDING GOVERNMENTAL AGENCY.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries. Information in this document supersedes and replaces all information previously supplied. The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2013 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan -Malaysia - Malta - Morocco - Philippines - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com



单击下面可查看定价,库存,交付和生命周期等信息

>>STMicro(意法半导体)